Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/840,192	FUJIKAWA ET	AL.
Examiner	Art Unit	
EDMUND H. LEE	1791	

	SEAR	CHED	
Class	Subclass	Date	Examiner
_	-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	0.000			
		71		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
· V		DATE	EXMR
264/259,255	9/:	30/2008	EHL
east			
inventor			